Search Notes

Application/Control No.	App
09/942,560	lw/
Examiner	Art

Hanh Nguyen

Applicant(s)/Patent under Reexamination IWASAKI ET AL. Art Unit

SEARCHED				
Class	Subclass	Date	Examiner	
370	468	11/9/2005	HN	
	395.41			
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398	45			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	468	11/9/2005	HN	
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